

<b>Notice of References Cited</b>	Application/Control No. 10/686,990	Applicant(s)/Patent Under Reexamination JOHNSON, GARY	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,521,841 A	05-1996	Arman et al.	715/723
*	B	US-5,634,020 A	05-1997	Norton, Mark J.	715/727
*	C	US-5,664,216 A	09-1997	Blumenau, Trevor	715/500.1
*	D	US-5,682,326 A	10-1997	Klingler et al.	715/500.1
*	E	US-5,732,184 A	03-1998	Chao et al.	386/55
*	F	US-5,892,507 A	04-1999	Moorby et al.	715/500.1
*	G	US-5,930,446 A	07-1999	Kanda, Takeshi	386/52
*	H	US-6,154,600 A	11-2000	Newman et al.	386/4
*	I	US-6,154,601 A	11-2000	Yaegashi et al.	386/52
*	J	US-6,188,396 B1	02-2001	Boezeman et al.	715/500.1
*	K	US-6,204,840 B1	03-2001	Petelycky et al.	715/500.1
*	L	US-6,262,776 B1	07-2001	Griffits, Laurence Kelvin	348/512
*	M	US-2001/0020953 A1	09-2001	Moriwake et al.	345/723

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,314,403 B1	11-2001	Jeffery, Mark R.	704/500
*	B	US-6,404,978 B1	06-2002	Abe, Keiko	386/55
*	C	US-6,414,686 B1	07-2002	Protheroe et al.	345/474
*	D	US-2002/0140719 A1	10-2002	Amir et al.	345/716
*	E	US-6,477,315 B1	11-2002	Ohomori, Shigeru	386/55
*	F	US-6,546,188 B1	04-2003	Ishii et al.	386/52
*	G	US-2003/0164845 A1	09-2003	Fayan et al.	345/722
*	H	US-6,650,826 B1	11-2003	Hatta, Masashi	386/52
*	T	US-6,658,194 B1	12-2003	Omori, Shigeru	386/52
*	J	US-2004/0001079 A1	01-2004	Zhao et al.	345/719
*	K	US-2004/0001694 A1	01-2004	Evans et al.	386/68
*	L	US-2004/0012594 A1	01-2004	Gauthier et al.	345/473
*	M	US-2004/0027369 A1	02-2004	Kellock et al.	345/716

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,744,968 B1	06-2004	Imai et al.	386/52
*	B	US-2004/0151469 A1	08-2004	Engholm et al.	386/052
*	C	US-6,848,117 B1	01-2005	Emura, Koichi	725/87
*	D	US-2005/0042591 A1	02-2005	Bloom et al.	434/307.00A
*	E	US-2005/0025320 A1	02-2005	Barry, James Anthony	381/119
*	F	US-6,873,344 B2	03-2005	Samra et al.	715/723
*	G	US-6,928,613 B1	08-2005	Ishii et al.	715/726
*	H	US-2005/0201724 A1	09-2005	Chu, Sandy	386/068
*	I	US-2005/0216840 A1	09-2005	Salvucci, Keith	715/723
*	J	US-7,020,381 B1	03-2006	Kato et al.	386/52
*	K	US-7,043,137 B2	05-2006	Slone, Derek	386/55
*	L	US-7,073,127 B2	07-2006	Zhao et al.	715/719
*	M	US-2006/0168521 A1	07-2006	Shimizu et al.	715/530

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	S					
	T					

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0150072 A1	07-2006	Salvucci, Keith D.	715/500.1
*	B	US-2006/0253781 A1	11-2006	Pea et al.	715/723
*	C	US-7,194,676 B2	03-2007	Fayan et al.	715/501.1
	D	US-			
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	N					
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